

IGBT – Power, Co-PAK

N-Channel, Field Stop VII (FS7), Non SCR, Power TO247-3L, 1200 V, 1.7 V, 75 A

FGY75T120SWD

Description

Using the novel field stop 7th generation IGBT technology and the Gen7 Diode in TO247 3-lead package, FGY75T120SWD offers the optimum performance with low switching and conduction losses for high-efficiency operations in various applications like Solar, UPS and ESS.

Features

- Maximum Junction Temperature – $T_J = 175^\circ\text{C}$
- Positive Temperature Coefficient for Easy Parallel Operation
- High Current Capability
- Smooth and Optimized Switching
- Low Switching Loss
- RoHS Compliant

Applications

- Boost and Inverter in Solar System
- UPS
- Energy Storage System

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

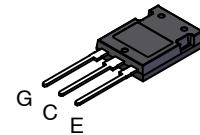
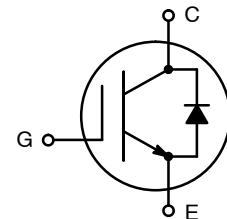
Parameter		Symbol	Value	Unit
Collector-to-Emitter Voltage		V_{CES}	1200	V
Gate-to-Emitter Voltage		V_{GES}	± 20	
			± 30	
Collector Current	$T_C = 25^\circ\text{C}$	I_C	150	A
	$T_C = 100^\circ\text{C}$		75	
Power Dissipation	$T_C = 25^\circ\text{C}$	P_D	714	W
	$T_C = 100^\circ\text{C}$		357	
Pulsed Collector Current	$T_C = 25^\circ\text{C}$, $t_p = 10 \mu\text{s}$ (Note 1)	I_{CM}	300	A
Diode Forward Current	$T_C = 25^\circ\text{C}$	I_F	150	
	$T_C = 100^\circ\text{C}$		75	
Pulsed Diode Maximum Forward Current	$T_C = 25^\circ\text{C}$, $t_p = 10 \mu\text{s}$ (Note 1)	I_{FM}	300	
Operating Junction and Storage Temperature Range		T_J , T_{STG}	-55 to 175	°C
Lead Temperature for Soldering Purposes		T_L	260	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive rating: pulse width limited by max. Junction temperature.

BV_{CES}	$V_{CE(\text{SAT})}$	I_C
1200 V	1.7 V	75.0 A

PIN CONNECTIONS



TO247-3LD
CASE 340CD

MARKING DIAGRAM



\$Y = onsemi Logo
 &Z = Assembly Plant Code
 &3 = 3-Digit Date Code
 &K = 2-Digit Lot Traceability Code
 FGY75T120SWD = Specific Device code

ORDERING INFORMATION

Device	Package	Shipping
FGY75T120SWD	TO247-3LD (Pb-Free)	30 Units / Tube

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case for IGBT	$R_{\theta,JC}$	0.21	°C/W
Thermal Resistance, Junction-to-Case for Diode		0.35	
Thermal Resistance, Junction-to-Ambient	$R_{\theta,JA}$	40	

ELECTRICAL CHARACTERISTICS OF THE IGBT ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Collector-to-Emitter Breakdown Voltage	BV_{CES}	$V_{GE} = 0 \text{ V}, I_C = 5 \text{ mA}$	1200	—	—	V
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{CES} / \Delta T_J$	$V_{GE} = 0 \text{ V}, I_C = 5 \text{ mA}$	—	1223	—	mV/°C
Collector-to-Emitter Cut-Off Current	I_{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = V_{CES}$	—	—	40	μA
Gate-to-Emitter Leakage Current	I_{GES}	$V_{GE} = 20 \text{ V}, V_{CE} = 0 \text{ V}$	—	—	±400	nA

ON CHARACTERISTICS

Gate-to-Emitter Threshold Voltage	$V_{GE(\text{TH})}$	$V_{GE} = V_{CE}, I_C = 75 \text{ mA}$	5.6	6.55	7.4	V
Collector-to-Emitter Saturation Voltage	$V_{CE(\text{SAT})}$	$V_{GE} = 15 \text{ V}, I_C = 75 \text{ A}, T_J = 25^\circ\text{C}$	1.35	1.68	2.0	V
		$V_{GE} = 15 \text{ V}, I_C = 75 \text{ A}, T_J = 175^\circ\text{C}$	—	2.24	—	

DYNAMIC CHARACTERISTICS

Input Capacitance	C_{IES}	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V}, f = 1 \text{ MHz}$	—	6331	—	pF
Output Capacitance	C_{OES}	—	234	—		
Reverse Transfer Capacitance	C_{RES}	—	29.6	—		
Total Gate Charge	Q_G	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}, I_C = 75 \text{ A}$	—	214	—	nC
Gate-to-Emitter Charge	Q_{GE}		—	53.9	—	
Gate-to-Collector Charge	Q_{GC}		—	77.7	—	

SWITCHING CHARACTERISTIC, INDUCTIVE LOAD

Turn-On Delay Time	$t_{d(\text{on})}$	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}, I_C = 37.5 \text{ A}, R_G = 4.7 \Omega, T_J = 25^\circ\text{C}$	—	42	—	ns
Turn-Off Delay Time	$t_{d(\text{off})}$		—	221	—	
Rise Time	t_r		—	27	—	
Fall Time	t_f		—	77	—	
Turn-On Switching Loss	E_{on}	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}, I_C = 75 \text{ A}, R_G = 4.7 \Omega, T_J = 25^\circ\text{C}$	—	2.12	—	mJ
Turn-Off Switching Loss	E_{off}		—	1.43	—	
Total Switching Loss	E_{ts}		—	3.55	—	
Turn-On Delay Time	$t_{d(\text{on})}$		—	42	—	
Turn-Off Delay Time	$t_{d(\text{off})}$	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}, I_C = 75 \text{ A}, R_G = 4.7 \Omega, T_J = 25^\circ\text{C}$	—	171	—	ns
Rise Time	t_r		—	56	—	
Fall Time	t_f		—	66	—	
Turn-On Switching Loss	E_{on}		—	5.00	—	mJ
Turn-Off Switching Loss	E_{off}	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}, I_C = 75 \text{ A}, R_G = 4.7 \Omega, T_J = 25^\circ\text{C}$	—	2.32	—	
Total Switching Loss	E_{ts}		—	7.32	—	

FGY75T120SWD

ELECTRICAL CHARACTERISTICS OF THE IGBT ($T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
SWITCHING CHARACTERISTIC, INDUCTIVE LOAD						
Turn-On Delay Time	$t_{d(on)}$	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}, I_C = 37.5 \text{ A}, R_G = 4.7 \Omega, T_J = 25^\circ\text{C}$	–	38	–	ns
Turn-Off Delay Time	$t_{d(off)}$		–	276	–	
Rise Time	t_r		–	26	–	
Fall Time	t_f		–	132	–	
Turn-On Switching Loss	E_{on}		–	3.50	–	mJ
Turn-Off Switching Loss	E_{off}		–	2.31	–	
Total Switching Loss	E_{ts}		–	5.81	–	
Turn-On Delay Time	$t_{d(on)}$	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}, I_C = 75 \text{ A}, R_G = 4.7 \Omega, T_J = 25^\circ\text{C}$	–	38	–	ns
Turn-Off Delay Time	$t_{d(off)}$		–	210	–	
Rise Time	t_r		–	53	–	
Fall Time	t_f		–	115	–	
Turn-On Switching Loss	E_{on}		–	7.29	–	mJ
Turn-Off Switching Loss	E_{off}		–	3.50	–	
Total Switching Loss	E_{ts}		–	10.79	–	
DIODE CHARACTERISTIC						
Diode Forward Voltage	V_F	$I_F = 75 \text{ A}, T_J = 25^\circ\text{C}$	1.62	1.84	2.22	V
		$I_F = 75 \text{ A}, T_J = 175^\circ\text{C}$	–	1.91	–	
DIODE SWITCHING CHARACTERISTIC, INDUCTIVE LOAD						
Reverse Recovery Time	t_{rr}	$V_R = 600 \text{ V}, I_F = 37.5 \text{ A}, dI_F/dt = 1000 \text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$	–	136	–	ns
Reverse Recovery Charge	Q_{rr}		–	2340	–	nC
Reverse Recovery Energy	E_{rec}		–	0.7	–	mJ
Peak Reverse Recovery Current	I_{RRM}		–	34.5	–	A
Reverse Recovery Time	t_{rr}	$V_R = 600 \text{ V}, I_F = 75 \text{ A}, dI_F/dt = 1000 \text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$	–	204	–	ns
Reverse Recovery Charge	Q_{rr}		–	3974	–	nC
Reverse Recovery Energy	E_{rec}		–	1.3	–	mJ
Peak Reverse Recovery Current	I_{RRM}		–	38.8	–	A
Reverse Recovery Time	t_{rr}	$V_R = 600 \text{ V}, I_F = 37.5 \text{ A}, dI_F/dt = 1000 \text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	–	236	–	ns
Reverse Recovery Charge	Q_{rr}		–	5980	–	nC
Reverse Recovery Energy	E_{rec}		–	2.1	–	mJ
Peak Reverse Recovery Current	I_{RRM}		–	50.7	–	A
Reverse Recovery Time	t_{rr}	$V_R = 600 \text{ V}, I_F = 75 \text{ A}, dI_F/dt = 1000 \text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	–	334	–	ns
Reverse Recovery Charge	Q_{rr}		–	9544	–	nC
Reverse Recovery Energy	E_{rec}		–	3.5	–	mJ
Peak Reverse Recovery Current	I_{RRM}		–	57.1	–	A

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

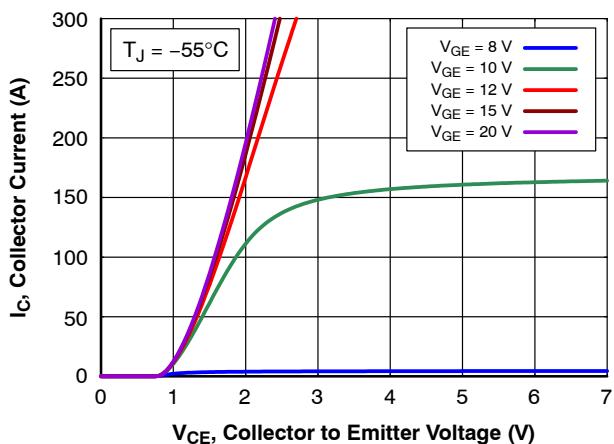


Figure 1. Output Characteristics

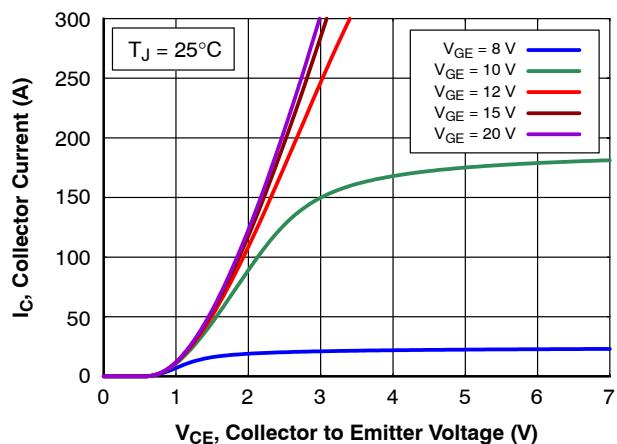


Figure 2. Output Characteristics

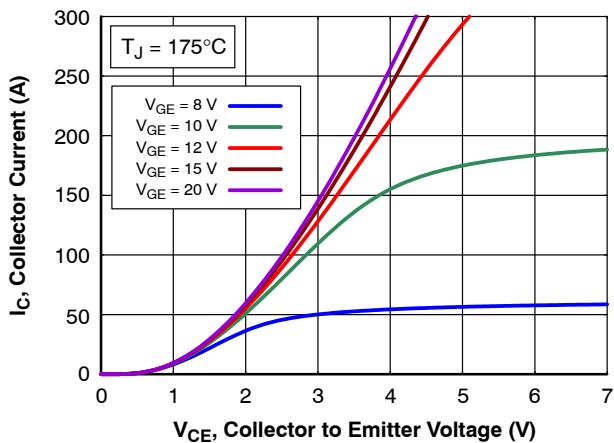


Figure 3. Output Characteristics

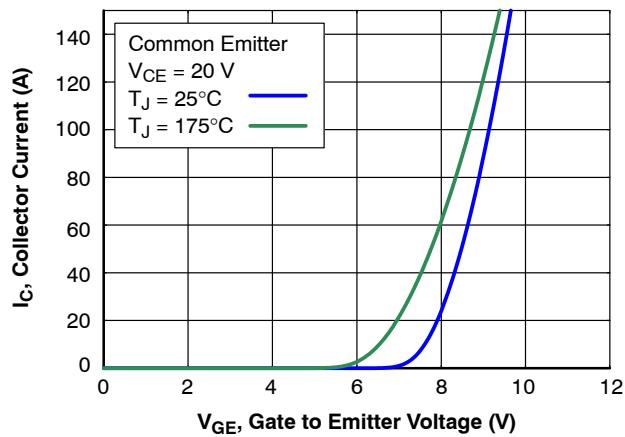


Figure 4. Transfer Characteristics

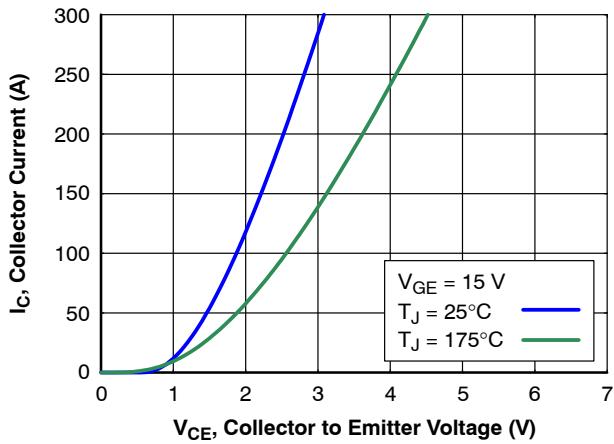


Figure 5. Saturation Voltage Characteristics

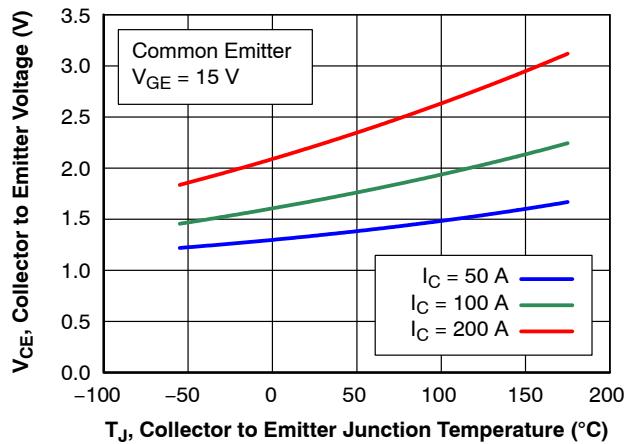
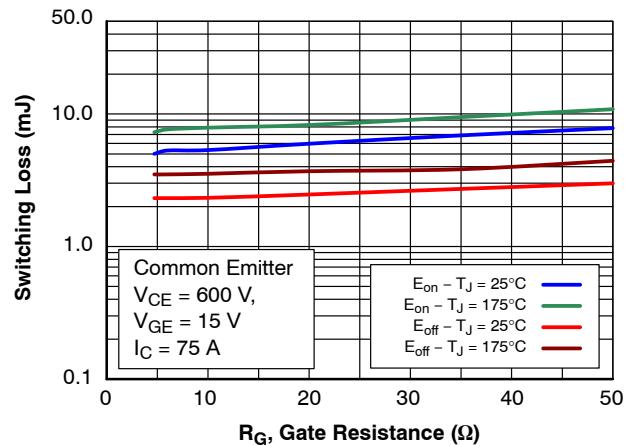
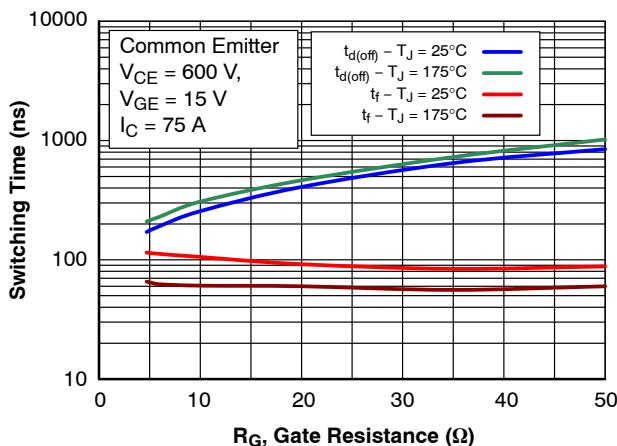
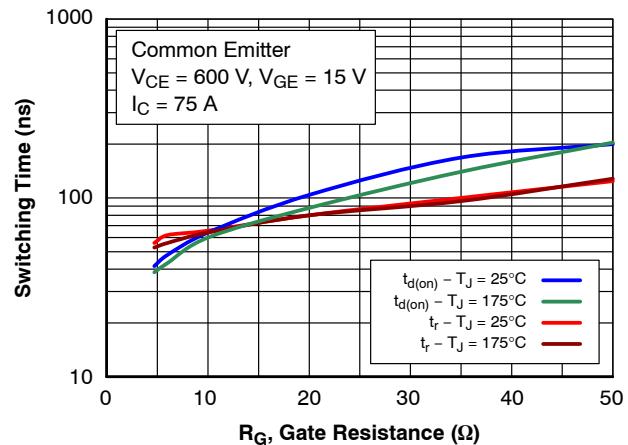
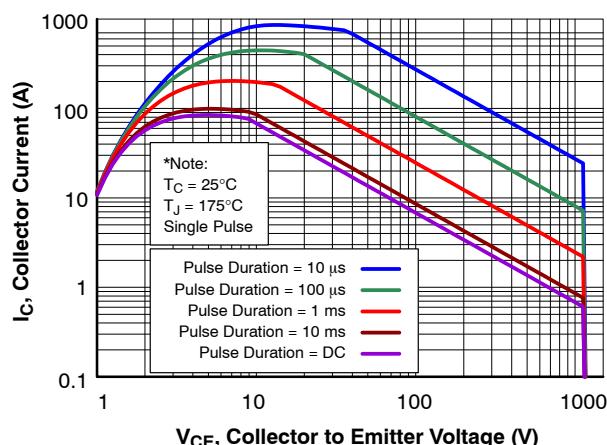
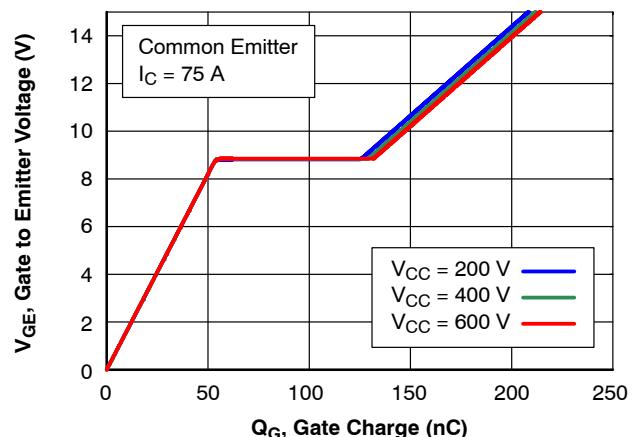
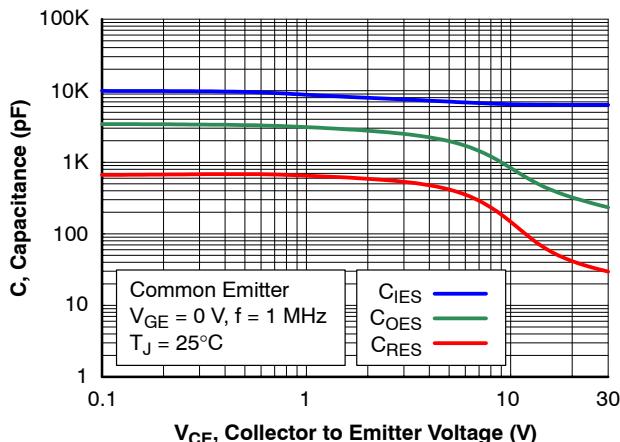


Figure 6. Saturation Voltage vs Junction Temperature

TYPICAL CHARACTERISTICS (CONTINUED)



TYPICAL CHARACTERISTICS (CONTINUED)

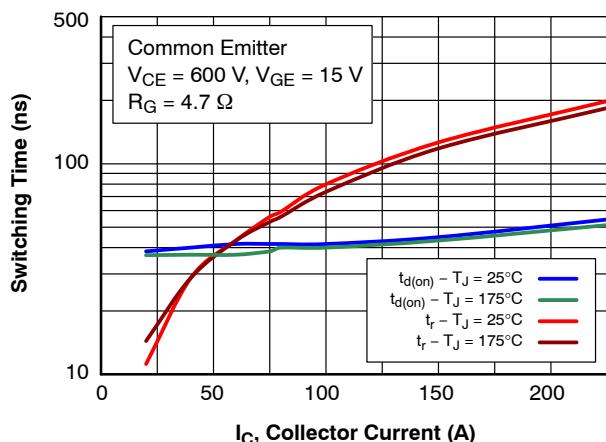


Figure 13. Turn-On Time vs Collector Current

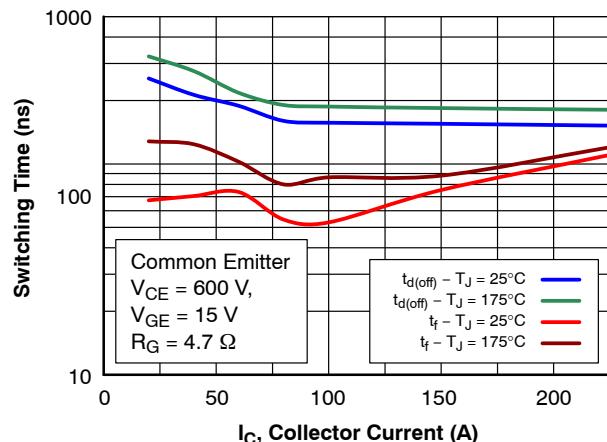


Figure 14. Turn-Off Time vs Collector Current

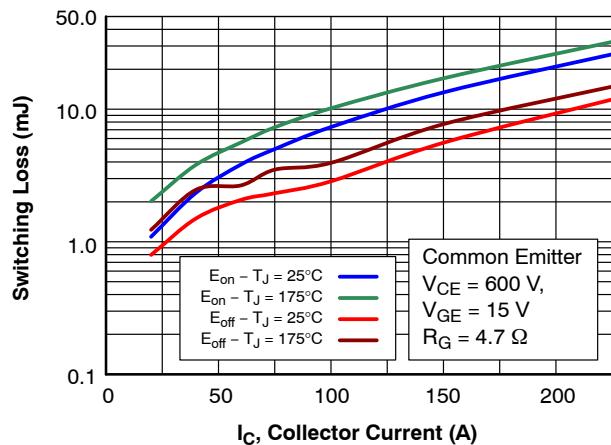


Figure 15. Switching Loss vs Collector Current

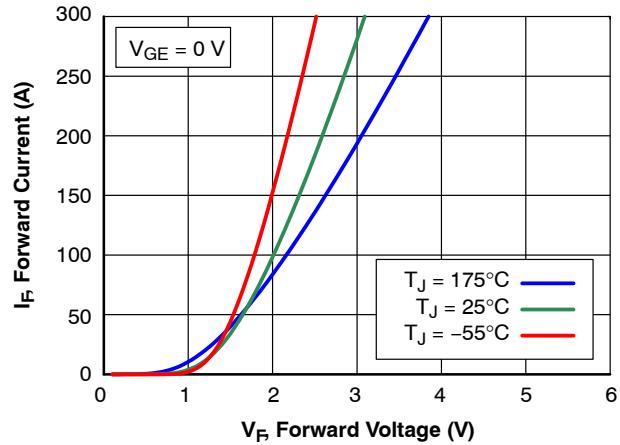


Figure 16. Diode Forward Characteristics

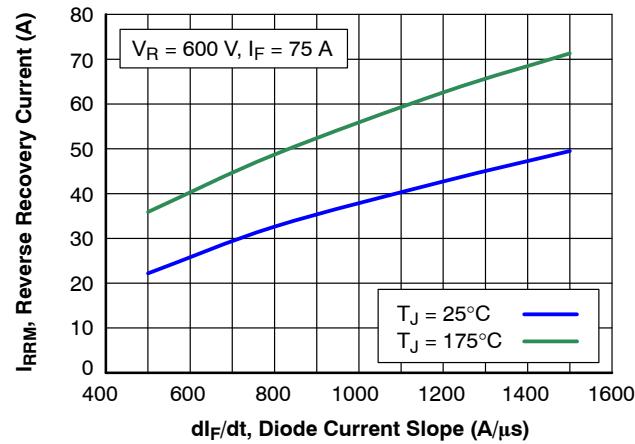


Figure 17. Diode Reverse Recovery Current

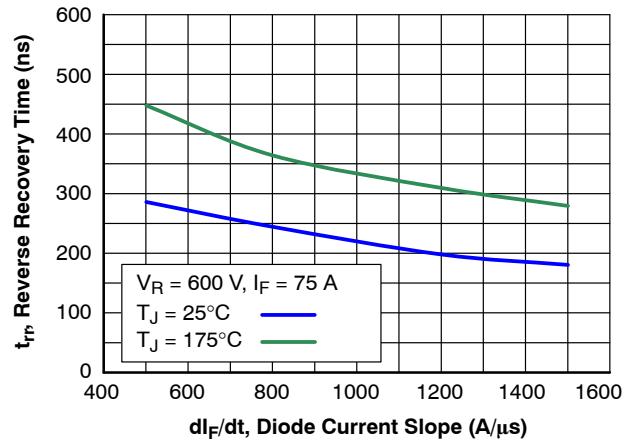


Figure 18. Diode Reverse Recovery Time

TYPICAL CHARACTERISTICS (CONTINUED)

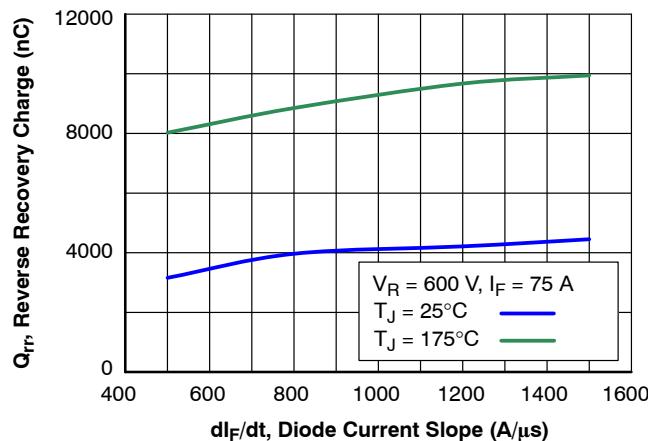


Figure 19. Diode Stored Charge Characteristics

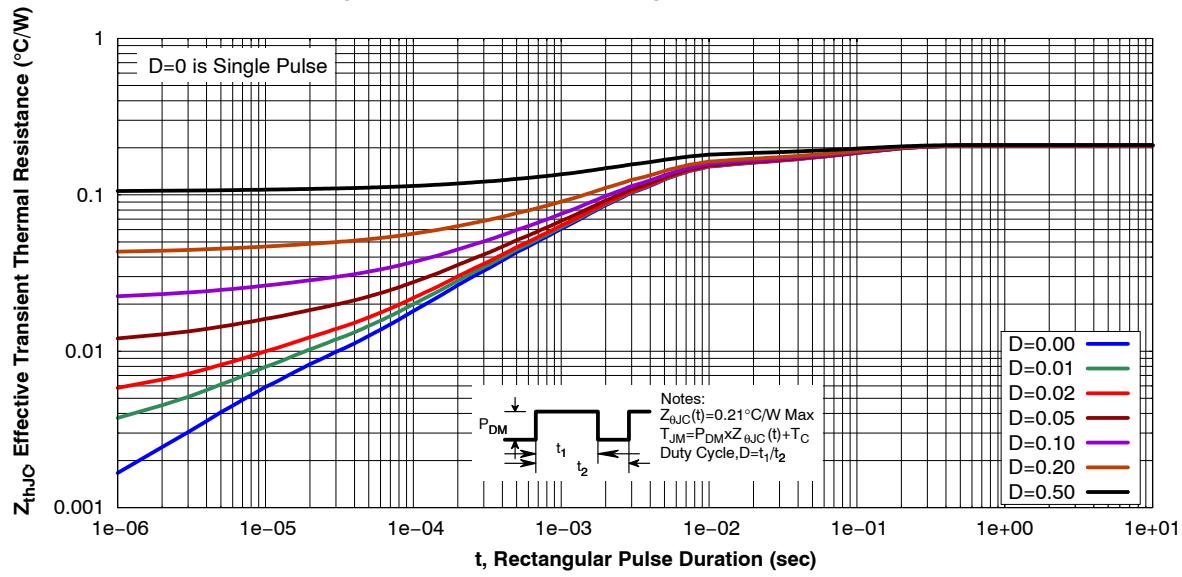


Figure 20. Transient Thermal Impedance of IGBT

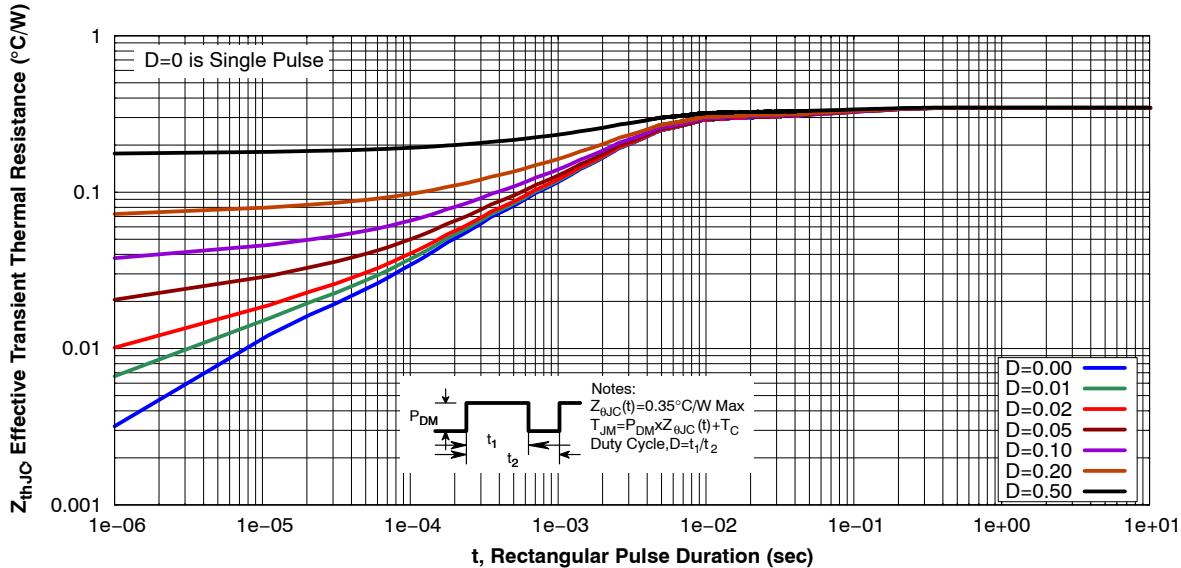
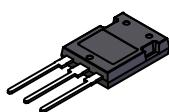


Figure 21. Transient Thermal Impedance of Diode

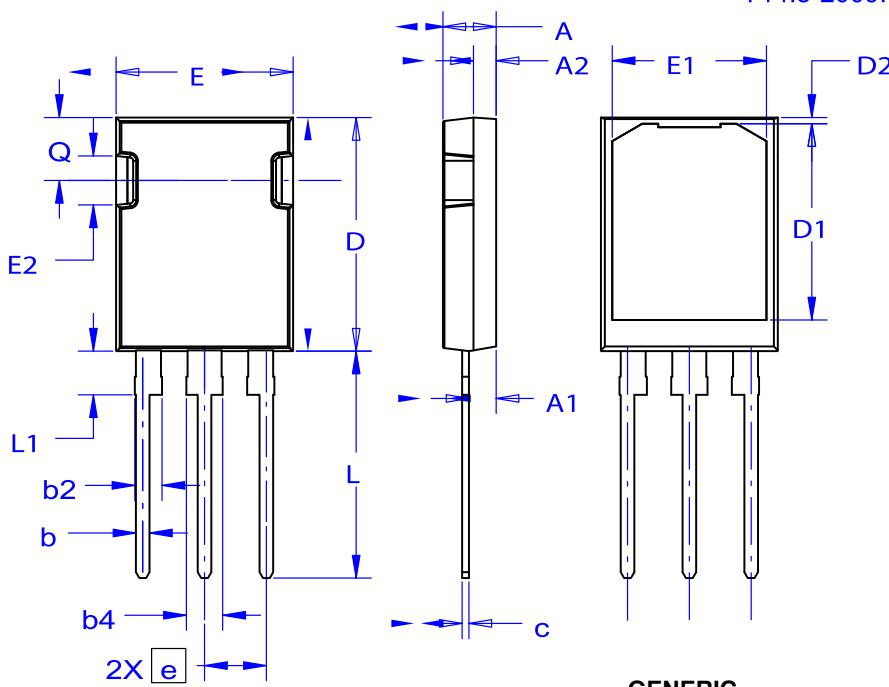


TO-247-3LD
CASE 340CD
ISSUE A

DATE 18 SEP 2018

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- D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.



GENERIC
MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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